

FORM PTO 1449 (modified)			ATTY DOCKET NO. 03500.017825	APPLICATION NO. 10/533,564		
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			APPLICANT TATSUYA IWASAKI			
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			FILING DATE 371(c) Date: May 3, 2005	GROUP 28742 2883		
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>mpm</i>	2005/0129348	06/16/2005	Iwasaki	385	14	
	6,278,231	08/21/2001	Iwasaki, et al.	313	310	
	6,838,297	01/04/2005	Iwasaki, et al.	438	20	
	5,357,122	10/18/1994	Okubora, et al.	257	84	
<i>mpm</i>	5,191,219	03/02/1993	Linke	250	551	
FOREIGN PATENT DOCUMENTS						
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
<i>mpm</i>	2004/093354	PCT/WO			<i>N/A</i>	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
<i>mpm</i>	Hideo Itoh, et al., "Multidimensional Optical Interconnections Using Beam-Scanning Laser Diodes", Electronics and Communications in Japan, Part II: Electronics, Scripta Technica, New York, U.S., Vol. 75, No. 11, (11/01/1992), pp. 32-41, XP000381545, ISSN: 8756-663X.					
EXAMINER	<i>Michael P. Mooney</i>		DATE CONSIDERED	<i>1-7-07</i>		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>MPLM</i>		9-107330	1997-04-22	Japan			Abstract
		2000-261383	2000-09-22	Japan			Abstract
		5-183515	1993-07-23	Japan			Abstract
		8-181654	1996-07-12	Japan			Abstract
<i>MPLM</i>		9-307502	1997-11-28	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <i>Mark J.P. Morris</i>	DATE CONSIDERED <i>1-7-07</i>						

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